

**Search Notes**

Application/Control No.

10/815,573

Examiner

Phallaka Kik

Applicant(s)/Patent under  
Reexamination

YE ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	4, 21	11/7/2005	PK
700	97,120	11/7/2005	PK
700	121	11/7/2005	PK
430	5	11/7/2005	PK
378	35	11/7/2005	PK
382	144,154	11/7/2005	PK
382	248, 283	11/7/2005	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	4, 21	11/9/2005	PK
700	97,120	11/9/2005	PK
700	121	11/9/2005	PK
430/5; 378/35; 382/144,154,248,283 --USPGPUB (see attached)		11/9/2005	PK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/Sub searched: 716/1-21; 700/97,120-121; 430/4-5; 378/34-35 (see attached)	11/7/2005	PK
BRS (EAST) (Con't) --USPAT, USPGPUB Cls/Sub searched: 382/144,154,237,248-250, 280, 283 (see attached)	11/7/2005	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	11/7/2005	PK
IEE/IEEE Xplore (see attached)	11/7/2005	PK